



Sheet 1 of 2

Form PTO-1449
(REV. 1/06)

US Dept. of Commerce
PATENT & TRADEMARK OFFICE

ATTY DOCKET NO.
115572.04

APPLICATION NO.
10/524,112

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Harlan Arthur HURWITZ et al.

FILING DATE
December 9, 2005

GROUP
3696

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EXAMINER

/John Scarito/

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01/17/2010

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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 115572.04		APPLICATION NO. 10/524,112	
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